

**Search Notes****Application/Control No.**

10/656,158

**Examiner**

Hong Cho

**Applicant(s)/Patent under Reexamination**

PARK ET AL.

**Art Unit**

2616

**SEARCHED**

Class	Subclass	Date	Examiner
370	229-232, 252-254, 328	3/28/2007	HC
	389, 392,		
	400, 401		
	466		
above	UPDATED	9/6/2007	HC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
370/229-232, 252-254, 328, 389, 392, 400, 401, 466 (text search - see search history printout)	4/2/2007	HC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner